

| | | | |
|-----------------------------------|-------------------------|---|-------------|
| Notice of References Cited | Application/Control No. | Applicant(s)/Patent Under Reexamination | |
| | 10/618,115 | WEIRAUCH, CHARLES R. | |
| Examiner | Art Unit | 2627 | Page 1 of 1 |
| Tawfik Goma | | | |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|----------------------|----------------|
| * | A | US-5,119,363 | 06-1992 | Satoh et al. | 369/275.3 |
| * | B | US-6,278,672 | 08-2001 | Kobayashi, Yoshihiro | 369/53.23 |
| * | C | US-5,684,773 | 11-1997 | Hayashi, Hideki | 369/47.35 |
| | D | US- | | | |
| | E | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| | | |
|---|---|---|
| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.